

MOSFET - N-Channel, QFET

100 V, 15.6 A, 100 mΩ

FQD19N10L

Description

This N-Channel enhancement mode power MOSFET is produced using **onsemi**'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on–state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, DC motor control, and variable switching power applications.

Features

- 15.6 A, 100 V, $R_{DS(on)} = 100 \text{ m}\Omega$ (Max.) @ $V_{GS} = 10 \text{ V}$
- Low Gate Charge (Typ. 14 nC)
- Low Crss (Typ. 35 pF)
- 100% Avalanche Tested

ABSOLUTE MAXIMUM RATINGS (T_C = 25°C, unless otherwise noted)

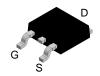
Symbol	Parameter		Ratings	Unit
V_{DSS}	Drain-Source Voltage		100	V
I _D	Drain Current	– Continuous ($T_C = 25^{\circ}C$)	15.6	Α
		– Continuous ($T_C = 100^{\circ}C$)	9.8	Α
I _{DM}	Drain Current	- Pulsed (Note 1)	62.4	Α
V_{GSS}	Gate-Source Voltage		±20	V
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		220	mJ
I _{AR}	Avalanche Current (Note 1)		15.6	Α
E _{AR}	Repetitive Avalanche Energy (Note 1)		5.0	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		6.0	V/ns
P _D	Power Dissipation (T _A = 25°C) *		2.5	W
	Power Dissipation (T _C = 25°C)		50	W
	− Derate Above 25°C		0.4	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds		300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{\theta JC}$	Thermal Resistance Junction to Case, Max.		°C/W
$R_{\theta JA}$	R _{θJA} Thermal Resistance, Junction to Ambient (Minimum Pad of 2–oz Copper), Max.		
	Thermal Resistance, Junction to Ambient (*1 in ² Pad of 2–oz Copper), Max.	50	

V _{DSS}	R _{DS(on)} MAX	I _D MAX
100 V	100 mΩ @ 10 V	15.6 A



DPAK3 (TO-252 3 LD) CASE 369AS

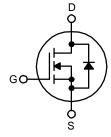
MARKING DIAGRAM

&Z&3&K FQD 19N10L

&Z = Assembly Plant Code &3 = 3-Digit Date Code

&K = 2-Digits Lot Run Traceability Code

FQD19N10L = Device Code



N-Channel MOSFET

ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
OFF CHAR	ACTERISTICS				•	
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	100	_	_	V
$\Delta BV_{DSS} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C	_	0.09	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 100 V, V _{GS} = 0 V	-	_	1	μΑ
	1	V _{DS} = 80 V, T _C = 125°C	_	_	10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 20 V, V _{DS} = 0 V	-	_	100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$	-	_	-100	nA
ON CHARA	CTERISTICS					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.0	_	2.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 7.8 A V _{GS} = 5 V, I _D = 7.8 A	- -	0.074 0.082	0.10 0.11	Ω
9FS	Forward Transconductance	V _{DS} = 30 V, I _D = 7.8 A	_	14	_	S
DYNAMIC C	CHARACTERISTICS					
C _{iss}	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$	_	670	870	pF
C _{oss}	Output Capacitance		_	160	210	pF
C _{rss}	Reverse Transfer Capacitance]	ı	35	45	pF
SWITCHING	CHARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 50 \text{ V}, I_D = 19 \text{ A}, R_G = 25 \Omega$	_	14	38	ns
t _r	Turn-On Rise Time	(Note 4)	-	410	830	ns
t _{d(off)}	Turn-Off Delay Time		_	20	50	ns
t _f	Turn-Off Fall Time		_	140	290	ns
Qg	Total Gate Charge	$V_{DS} = 80 \text{ V}, I_D = 19 \text{ A}, V_{GS} = 5 \text{ V}$	_	14	18	nC
Q _{gs}	Gate-Source Charge	(Note 4)	_	2.9	-	nC
Q_{gd}	Gate-Drain Charge		1	9.2	_	nC
DRAIN-SOL	URCE DIODE CHARACTERISTICS AND MAXII	MUM RATINGS		-	-	•
I _S	Maximum Continuous Drain-Source Diode Fo	orward Current	_	_	15.6	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forwar	mum Pulsed Drain-Source Diode Forward Current		_	62.4	Α
V_{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 15.6 A	-	_	1.5	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 19 A,	-	80	_	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100 A/\mu s$	_	0.195	_	μС

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1. Repetitive rating: pulse–width limited by maximum junction temperature.

2. L = 1.35 mH, I_{AS} = 15.6 A, V_{DD} = 25 V, R_{G} = 25 Ω , starting T_{J} = 25°C.

3. $I_{SD} \le 19$ A, di/dt ≤ 300 A/ μ s, $V_{DD} \le BV_{DSS}$, starting T_{J} = 25°C.

4. Essentially independent of operating temperature.

TYPICAL CHARACTERISTICS

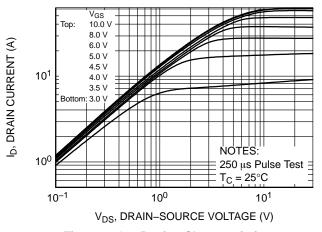


Figure 1. On-Region Characteristics

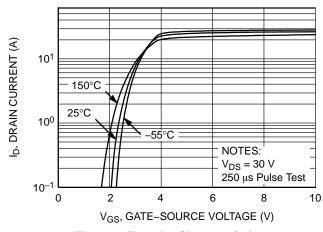


Figure 2. Transfer Characteristics

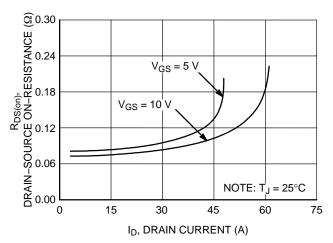


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

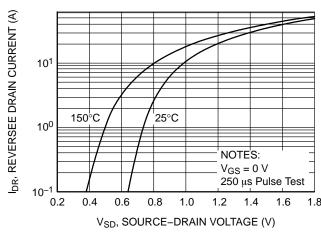


Figure 4. Body Diode Forward Voltage Variation vs.
Source Current and Temperature

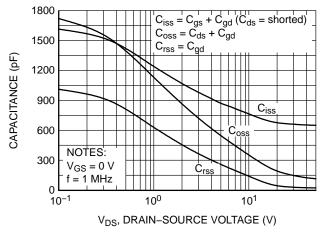


Figure 5. Capacitance Characteristics

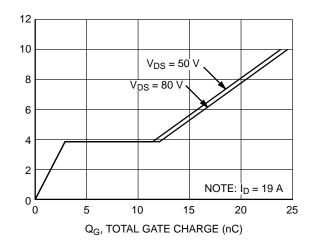


Figure 6. Gate Charge Characteristics

V_{GS}, GATE-SOURCE VOLTAGE (V)

TYPICAL CHARACTERISTICS (continued)

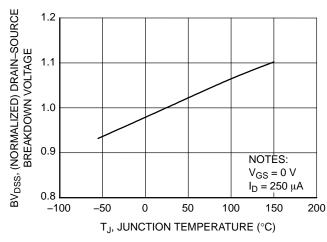


Figure 7. Breakdown Voltage Variation vs. Temperature

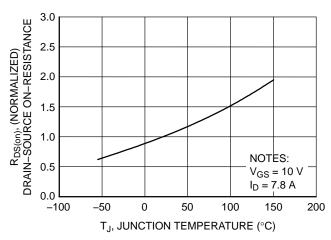


Figure 8. On-Resistance Variation vs. Temperature

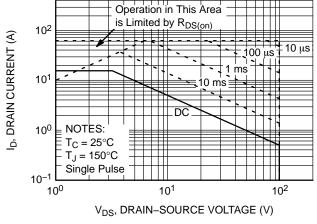


Figure 9. Maximum Safe Operating Area

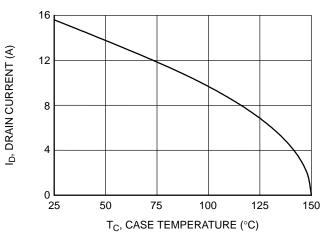


Figure 10. Maximum Drain Current vs.

Case Temperature

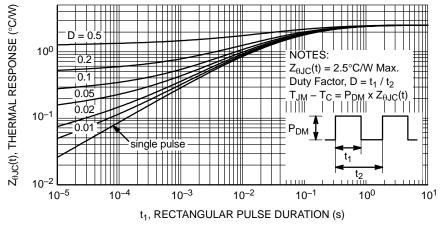


Figure 11. Transient Thermal Response Curve

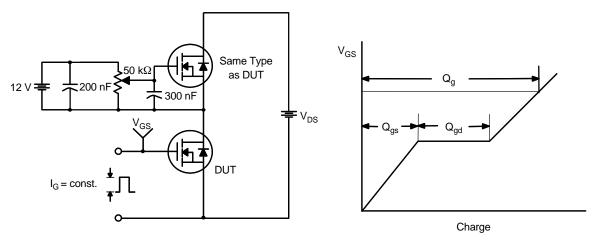


Figure 12. Gate Charge Test Circuit & Waveform

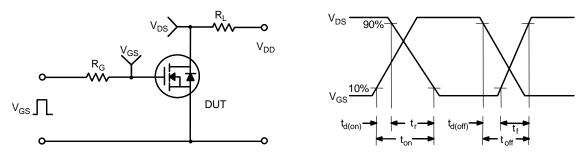


Figure 13. Resistive Switching Test Circuit & Waveforms

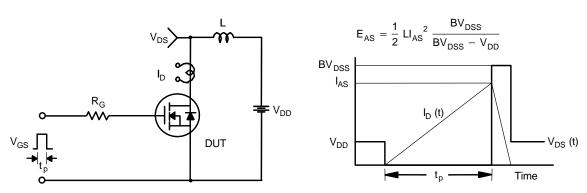


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms

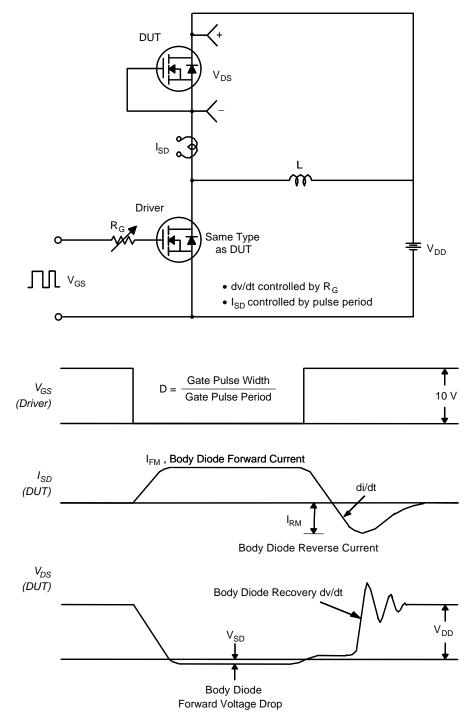


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

PACKAGE MARKING AND ORDERING INFORMATION

Device Device Marking		Package	Reel Size	Tape Width	Shipping [†]	
	FQD19N10LTM	FQD19N10L	DPAK3 (TO-252 3 LD)	330 mm	16 mm	2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





DPAK3 6.10x6.54x2.29, 4.57P CASE 369AS **ISSUE B**

DATE 20 DEC 2023

- NOTES: UNLESS OTHERWISE SPECIFIED

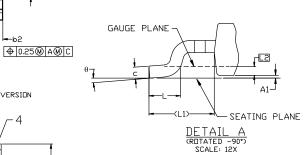
 A) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE F, VARIATION AA.

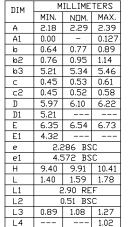
 B) ALL DIMENSIONS ARE IN MILLIMETERS.

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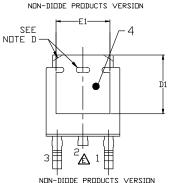
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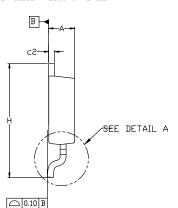
- A
- F)
- DIMENSIONING AND TOLERANCING PER
 ASME Y14.5M-2018.
 SUPPLIER DEPENDENT MOLD LOCKING HOLES OR CHAMFERED
 CORNERS OR EDGE PROTRUSION.
 FOR DIGDE PRODUCTS, L4 IS 0.25 MM MAX PLASTIC BODY
 STUB WITHOUT CENTER LEAD.
 DIMENSIONS ARE EXCLUSIVE OF BURRS,
 MOLD FLASH AND TIE BAR EXTRUSIONS.
 LAND PATTERN RECOMMENDATION IS BASED ON IPC7351A STD
 T0228P991X239-3N.





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Α

5.55	MIN-
	6.50 MIN
6.40 LXXX	
1	2.85 MIN
	1.25 MIN
4.5	2.286

LAND PATTERN RECOMMENDATION

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

GENERIC MARKING DIAGRAM*

10°

XXXXXX XXXXXX **AYWWZZ**

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

XXXX = Specific Device Code

= Assembly Location Α

Υ = Year

WW = Work Week

77 = Assembly Lot Code

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